The Space Group of β -Si₃N₄

BY P. GOODMAN* AND M. O'KEEFFE

Center for Solid State Science, Arizona State University, Tempe, Arizona 85281, USA

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Abstract

A new preparation of pure β -Si₃N₄ powder has permitted a study of the material by convergent-beam electron diffraction. This study has confirmed its classification in the space group $P6_3/m$.

Introduction

Silicon nitride is rapidly becoming one of the more important engineering ceramics. Two polymorphs, α and β -Si₃N₄, are known (Ruddlesden & Popper, 1958) and the conditions for their preparation and stability are currently the subject of intensive research. The crystal structure of α -Si₃N₄ is now well known (Kato, Inoue, Kijima, Kawada & Tanaka, 1975); however, the difficulty of preparing good single crystals of β -Si₃N₄ has hindered an accurate structure determination. On the basis of a study of an impure powder, Hardie &

* On leave from CSIRO, Melbourne, Australia.

Fig. 1. The 'selected-area' pattern from the $[11\overline{2}0]$ zone setting of Si₃N₄, used for the convergent-beam studies. The rectangular cell shown $(a^{\bullet} \times c^{\bullet})$ corresponds to the real-space cell of a = 6.6, c = 2.9 Å.

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Jack (1957) reported an approximate structure with symmetry $P6_1/m$. Subsequently Borgen & Seip (1961) redetermined the structure using diffraction data from a small single crystal. They used only hk0 reflections, as the mirror plane (in space group $P6_3/m$) fixes the z coordinates of all the atoms. Wild, Grieveson & Jack (1972) subsequently published a more precise structure, still with the same space group, that differed significantly from that of Borgen & Seip. Recently Grun (1977) proposed a sightly different structure, based on refinement of single-crystal X-ray data, with space group $P6_3$. This structure differed from that of Wild et al. (1972) mainly in displacements of three quarters of the N atoms by approximately 0.05 Å along the c axis. These displacements in turn result in changes in Si-N bond lengths by about the same amount. Thus two Si-N bond lengths of 1.730 Å in the Wild et al. (1972) structure become 1.689 and 1.763 Å in the Grun (1977) structure. As a knowledge of accurate bond lengths and bond angles plays a central role in discussions of bonding in crystals we have examined this structure using convergent-beam electron diffraction (CBED).



Fig. 2. The zone-axis convergent-beam pattern for [1120]. The lines *m* and m_p show the mirror lines which are only crudely visible in the pattern; the mirror line across m-m is partly obscured by the slight mis-setting of the illumination aperture relative to the zone axis. The extinction of intensity in the 0001/0001 reflexions is clearly seen at the ends of the arrows m_p .

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In the technique of CBED, unlike X-ray diffraction, the symmetry elements of a structure are examined directly and, in the case of a material such as Si_3N_4 where there is no great range over atomic number (Z = 14, 7 and for Si and N), mirror symmetries may be determined to a high accuracy.

Experiments and results

Si₃N₄ (from the Ventron Corporation) consisting of approximately equal amounts of α - and β -Si₃N₄ was converted to β -Si₃N₄ (as revealed by X-ray powder diffraction) after heating at 1973 K for 10 h in a 90% N₂ + 10% H₂ mixture. The resulting powder was found by electron microscopy to consist of platelets with faces parallel to the *c* axis. This morphology gave convenient access to the reflexions of the [1120] zone.





Fig. 3. The horizontal mirror line, scarcely discernible from Fig. 2, is made obvious in (a) and (b); these are convergent-beam patterns taken with the incident beam tilted to the zone axis, but symmetrically disposed across the mirror line, a^* (see text).



Fig. 4. The convergent-beam pattern taken with the incident cone of electrons tilted from the zone axis in the perpendicular direction from Fig. 3, *i.e.* symmetrically disposed about the c* axis. Note the extinction at the 0001 position (indicated by arrows).



Fig. 5. Wide-angle convergent beam from the [1120] zone axis. In this pattern can be seen the two mirror lines, (a) m-m and (b) m_p-m_p , from the three-dimensional mirror plane, and from the projective mirror symmetry, respectively. Also, it can be seen that the symmetry across m_p-m_p is not exact, but is broken by the differences occurring at the two bracketed positions in the picture. This break is a result of the three-dimensional interaction of electrons with the crystal potential within the dynamic scattering process.

The preparation was examined in a JEOL 100B electron microscope, set up for convergent-beam diffraction (Goodman, 1980). Results are shown in Figs. 1–5.

Fig. 1 shows the 'selected-area' point pattern from the [1120] zone axis. This serves to show the rectangular cell dimensions $6 \cdot 6 \times 2 \cdot 9$ Å (*i.e.* $\sqrt{3}a/2 \times c$). The scale of the diffraction pattern is given by the carbon halo shown which corresponds to the c-cspacing of 2 Å. In the remaining figures the CBED-Kossel pattern (wide-angle convergent beam) and apertured convergent-beam patterns display the relevant symmetry elements, as follows:

1. The [1120] zone-axis pattern of Fig. 2 shows the 2m symmetry of the projection. Note the 000*l*, l = 2n absences indicated by the dark band through the 0001 position.

2. Fig. 3(a) and (b) shows the patterns obtained from thin and thick crystals when the incident cone of electrons is parallel to the $\{000l\}$ planes but tilted several degrees to the $[11\bar{2}0]$ zone axis. This tilting increases the sensitivity of the pattern to any deviation from an [0001] mirror symmetry, by greatly increasing the zone of visible reflexions. In particular, the large tilt and large incident-cone semi-angle used for Fig. 3(b)bring up very many sharp defect lines within and around the direct (0000) beam. With these data we can verify the mirror plane in question (*i.e.* the mirror plane specific to $P6_3/m$ and absent from $P6_3$) to a high accuracy; certainly deviations of the order reported by Grun (1977) can be ruled out by this direct observation.

3. Fig. 4, taken with a tilt along the second axis, *i.e.* with the incident cone parallel to the $\{h\bar{h}00\}$ planes, shows the projective symmetry of the twofold screw axis. The absence of intensity at the 0001 position is in agreement with the twofold screw operator.

4. The wide-angle convergent-beam pattern of Fig. 5 which was taken at the $[11\bar{2}0]$ zone-axis setting has low contrast but an approximate 2m symmetry (the symmetry of the projection) can be seen. However, upon closer examination only the symmetry across the $[0001]^*$ line is exact.

Across the [1100]* axis a break in the symmetry (indicated on the figure) is in agreement with the well-known three-dimensional character of fastelectron-interaction crystal potential, and with the fact that its origin is not a mirror plane but the *projective* symmetry of a diad axis.

Conclusion

The above examination of β -Si₃N₄ shows accurate agreement with the $P6_3/m$ space group.

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The Structure of Cs₃CoCl₅ at 295 K: A Neutron Diffraction Study

By Geoffrey A. Williams* and Brian N. Figgis

School of Chemistry, The University of Western Australia, Nedlands, Western Australia 6009, Australia

AND FRANK H. MOORE

Australian Institute of Nuclear Science and Engineering, Sutherland, NSW 2232, Australia

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Abstract

The crystal structure of Cs₃CoCl₅ [tetragonal, *I4/mcm*, a = 9.2315 (15), c = 14.5535 (24) Å, U = 1240.3 Å³, Z = 4] has been determined at 295 K by the use of high-

* Present address: Australian Radiation Laboratory, Lower Plenty Road, Yallambie, Victoria 3085, Australia.

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accuracy single-crystal neutron diffraction data. Automatic diffractometry has provided Bragg intensities for 490 independent reflections with $0 < \sin \theta/\lambda \le$ 0.690 Å^{-1} , after equivalent reflections had been averaged. The structure was refined by full-matrix least-squares methods to R 0.023 and χ 1.454. Thermal-vibration parameters have been accurately © 1980 International Union of Crystallography